Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination	Applicant(s)/Patent under Reexamination	
10/829,251	LEE, JEONG SIK		
Examiner	Art Unit		
Brian K. Kauffman	3765		

	SEARCHED		
Class	Subclass	Date	Examiner
Updated	Search	12/21/2005	вкк
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Updated Search	12/21/2005	вкк
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